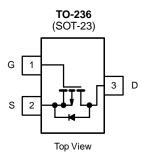


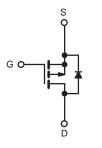
AFP3459TS6RG-VB Datasheet P-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	- 60			
R _{DS(on)} (Ω)	V _{GS} = - 10 V	0.05		
Q _g (Max.) (nC)	12			
Q _{gs} (nC)	3.8			
Q _{gd} (nC)	5.1			
Configuration	Single			

FEATURES

- · Isolated Package
- High Voltage Isolation = $2.5 \text{ kV}_{\text{RMS}}$ (t = 60 s; f = 60 Hz
- Sink to Lead Creepage Distance = 4.8 mm
- P-Channel
- 175 °C Operating Temperature
- Dynamic dV/dt Rating
- · Low Thermal Resistance
- Lead (Pb)-free Available





P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T	c = 25 °C, u	nless otherw	vise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	- 60	V	
Gate-Source Voltage			V _{GS}	± 20	v	
Continuous Drain Current	Vac at 10 V	$\frac{T_{C} = 25 \text{ °C}}{T_{C} = 100 \text{ °C}}$	I _D	- 5.2		
Continuous Drain Current	v _{GS} at - 10 v			- 3.8	A	
Pulsed Drain Current ^a			I _{DM}	- 21		
Linear Derating Factor				0.18	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	120	mJ	
Repetitive Avalanche Current ^a			I _{AR}	- 5.2	А	
Repetitive Avalanche Energy ^a			E _{AR}	2.7	mJ	
Maximum Power Dissipation	T _C = 25 °C		P _D	27	W	
Peak Diode Recovery dV/dt ^c			dV/dt	- 4.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	℃	
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d]	
Mounting Torque	6-32 or M3 screw			10	lbf · in	
				1.1	N·m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = -25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 5.0 mH, $R_G = 25 \Omega$, $I_{AS} = -5.3 \text{ A}$ (see fig. 12). c. $I_{SD} \leq -6.7 \text{ A}$, dl/dt $\leq 90 \text{ A/}\mu\text{s}$, $V_{DD} \leq V_{DS}$, $T_J \leq 175 \text{ °C}$.

d. 1.6 mm from case.

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PARAMETER	SYMBOL	TYP. MAX.			UNIT			
Maximum Junction-to-Ambient	R _{thJA}	- 65 - 5.5				00.044		
Maximum Junction-to-Case (Drain)	R _{thJC}				°C/W			
SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,	unless other	wise noted						
PARAMETER	SYMBOL	TES		ONS	MIN.	TYP.	MAX.	UNI
Static		·						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	0 V, I _D = - 2	50 µA	- 60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _C	₀ = - 1 mA	-	- 0.060	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{GS}, I_{D} = -2$	250 μA	- 1.0	-	- 2.5	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 \	/	-	-	± 100	nA
Zaro Cata Valtaga Drain Current	1	$V_{DS} = -60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		= 0 V	-	-	- 100	
zero Gale voltage Drain Current	o Gate Voltage Drain Current I_{DSS} $V_{DS} = -48 V_{GS} = 0 V, T_J = 150 °C$		J = 150 °C	-	-	- 500	μA	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D =	- 3.2 A ^b	-	0.05	-	Ω
Forward Transconductance	g fs	V _{DS} =	- 25 V, I _D = -	3.2 A ^b	1.6	-	-	S
Dynamic								
Input Capacitance	Ciss				-	270	-	pF
Output Capacitance	C _{oss}	$V_{GS} = 0 V,$ $V_{DS} = -25 V,$ f = 1.0 MHz, see fig. 5		-	170	-		
Reverse Transfer Capacitance	C _{rss}			-	31	-		
Drain to Sink Capacitance	С		f = 1.0 MHz		-	12	-	
Total Gate Charge	Qg	$V_{GS} = -10 \text{ V}$ $I_D = -4.7 \text{ A}, V_{DS} = -48 \text{ V},$ see fig. 6 and 13 ^b		-	-	12		
Gate-Source Charge	Q _{gs}			$V_{DS} = -48 V,$ 6 and 13 ^b	-	-	3.8	nC
Gate-Drain Charge	Q _{gd}		see lig. 6 and 15		-	-	5.1	
Turn-On Delay Time	t _{d(on)}	$V_{DD} = -30 \text{ V}, \text{ I}_{D} = -4.7 \text{ A}, \\ \text{R}_{G} = 24 \Omega, \text{ R}_{D} = 4.0 \Omega, \\ \text{see fig. } 10^{\text{b}}$		-	11	-	- ns	
Rise Time	t _r			-	63	-		
Turn-Off Delay Time	t _{d(off)}			-	9.6	-		
Fall Time	t _f			-	31	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH	
Internal Source Inductance	L _S			-	7.5	-		
Drain-Source Body Diode Characteristic	s	·						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	- 5.2	A	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	- 21		
Body Diode Voltage	V_{SD}	$T_J = 25 \ ^{\circ}\text{C}, \ I_S = -5.2 \ \text{A}, \ V_{GS} = 0 \ V^b$		-	-	- 5 .5	V	
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = - 4.7 A, dl/dt = 100 A/μs ^b		-	80	160	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	ij = 23 0, i _F	– • • • • •, ui/	αι – 100 Λ/μο ⁻	-	0.096	0.19	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-			on is dor	ninated by	/Ls and L	_n)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

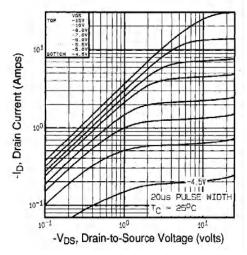


Fig. 1 - Typical Output Characteristics, T_C= 25 °C

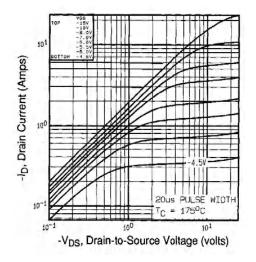


Fig. 2 - Typical Output Characteristics, T_C = 175 °C

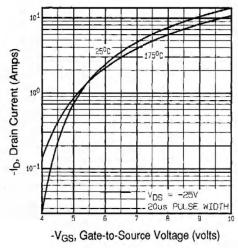


Fig. 3 - Typical Transfer Characteristics

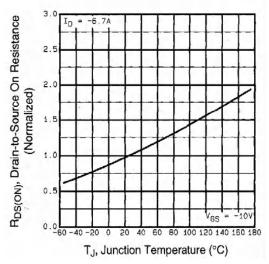


Fig. 4 - Normalized On-Resistance vs. Temperature



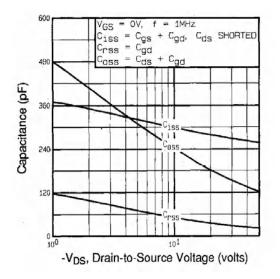
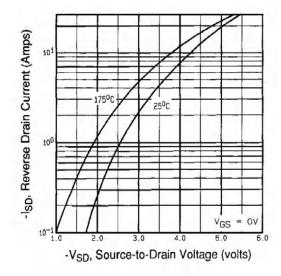
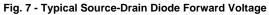


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage





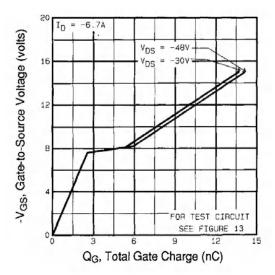
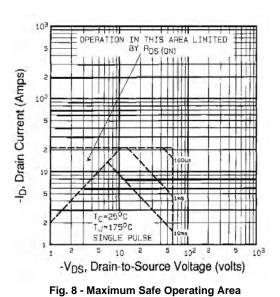


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





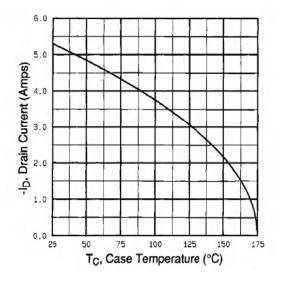


Fig. 9 - Maximum Drain Current vs. Case Temperature

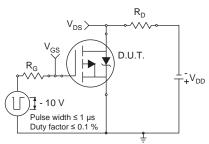


Fig. 10a - Switching Time Test Circuit

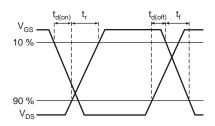
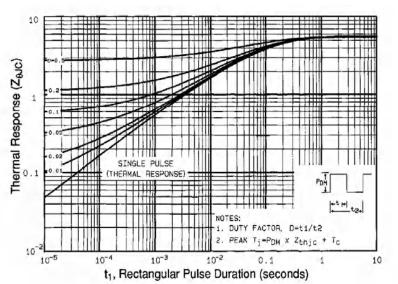
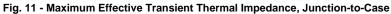


Fig. 10b - Switching Time Waveforms





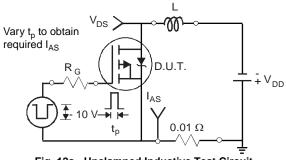
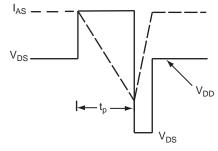
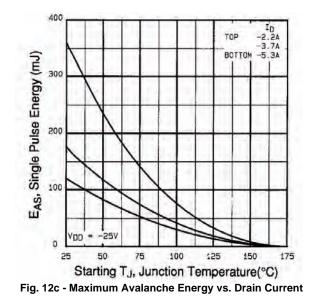


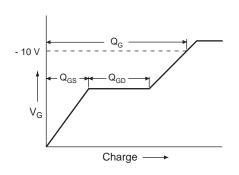
Fig. 12a - Unclamped Inductive Test Circuit











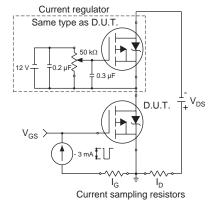
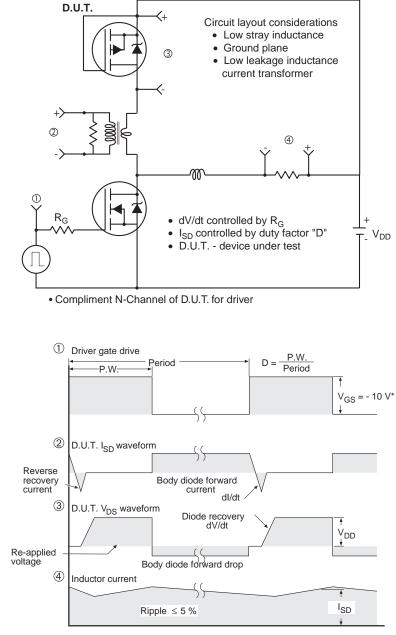


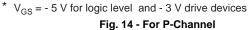
Fig. 13a - Basic Gate Charge Waveform

Fig. 13b - Gate Charge Test Circuit







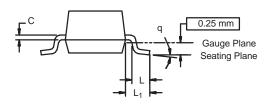




SOT-23 (TO-236): 3-LEAD



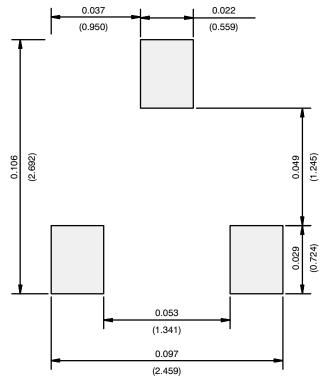




Dim –	MILLIM	IETERS	INCHES		
	Min	Max	Min	Max	
Α	0.89	1.12	0.035	0.044	
A ₁	0.01	0.10	0.0004	0.004	
A ₂	0.88	1.02	0.0346	0.040	
b	0.35	0.50	0.014	0.020	
C	0.085	0.18	0.003	0.007	
D	2.80	3.04	0.110	0.120	
E	2.10	2.64	0.083	0.104	
E ₁	1.20	1.40	0.047	0.055	
е	0.95 BSC		0.0374 Ref		
e ₁	1.90 BSC		0.0748 Ref		
L	0.40	0.60	0.016	0.024	
L ₁	0.64 Ref		0.025 Ref		
S	0.50 Ref		0.020 Ref		
q	3°	8°	3°	8°	



RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads Dimensions in Inches/(mm)



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